

# **Notice of References Cited**

Application/Control No.

09/725,862

Applicant(s)/Patent Under  
Reexamination  
GRECO ET AL.

Examiner

Joseph Nguyen

Art Unit

2815

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number		Date MM-YYYY	Name	Classification	
		Country	Code-Number-Kind Code				
	A	US-6229211B1		05-2001	Kawanoue et al	257	751
	B	US-6144099		11-2000	Lopatin et al	257	758
	C	US-6265780B1		07-2001	Yew et al	257	759
	D	US-5714418		02-1998	Bai et al	438	627
	E	US-6136682		10-2000	Hegde et al	438	622
	F	US-6187663B1		02-2001	Yu et al	438	624
	G	US-6222269B1		04-2001	Usami	257	758
	H	US-6221758B1		04-2001	Liu et al	438	626
	I	US-					
	J	US-					
	K	US-					
	L	US-					
	M	US-					

## **FOREIGN PATENT DOCUMENTS**

*		Document Number		Date MM-YYYY	Country	Name	Classification	
		Country	Code-Number-Kind Code					
	N							
	O							
	P							
	Q							
	R							
	S							
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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